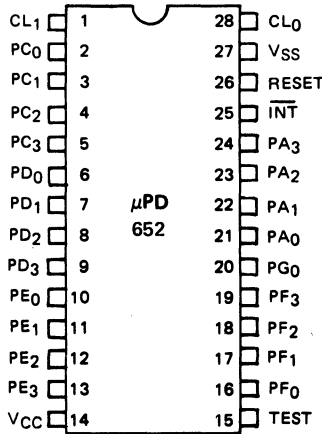


4-BIT SINGLE CHIP MICROCOMPUTER

DESCRIPTION The μPD652 is a μCOM-45 4-bit single chip microcomputer manufactured with a low-power-consumption CMOS process, allowing use of a single +5V power supply. The μPD652 provides all of the hardware features of the μCOM-45 family, and executes all 58 instructions of the μCOM-45 instruction set.

PIN CONFIGURATION



PIN NAMES

PA ₀ -PA ₃	Input Port A
PC ₀ -PC ₃	Input/Output Port C
PD ₀ -PD ₃	Input/Output Port D
PE ₀ -PE ₃	Output Port E
PF ₀ -PF ₃	Output Port F
PG ₀	Output Port G
$\overline{\text{INT}}$	Interrupt Input
CL ₀ -CL ₁	External Clock Signals
RESET	Reset
V _{CC}	Power Supply Positive
V _{SS}	Power Supply Negative
TEST	Factory Test Pin (Connect to V _{CC} .)

ABSOLUTE MAXIMUM RATINGS*

Operating Temperature	-30°C to +85°C
Storage Temperature	-55°C to +125°C
Supply Voltage	-0.3 to 7.0V
Input Voltages (Ports A, C, D, $\overline{\text{INT}}$, RESET)	-0.3 to 7.3V
Output Voltages	-0.3 to 7.3V
Output Current (Ports C through G, each bit)	-2.5 mA
(Total, all ports)	-28.0 mA

COMMENT: Stress above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

*T_a = 25°C

μ PD652

T_a = -30°C to +85°C; V_{CC} = +5V ± 10%

DC CHARACTERISTICS

PARAMETER	SYMBOL	LIMITS			UNIT	TEST CONDITIONS
		MIN	TYP	MAX		
Input Voltage High	V _{IH}	0.7 V _{CC}		V _{CC}	V	Ports A, C, D, $\overline{\text{INT}}$, RESET
Input Voltage Low	V _{IL}	0		0.3 V _{CC}	V	Ports A, C, D, $\overline{\text{INT}}$, RESET
Clock Voltage High	V _{φH}	0.7 V _{CC}		V _{CC}	V	CL ₀ Input, External Clock
Clock Voltage Low	V _{φL}	0		0.3 V _{CC}	V	CL ₀ Input, External Clock
Input Leakage Current High	I _{LIH}			+10	μA	Ports A, C, D, $\overline{\text{INT}}$, RESET, V _I = V _{CC}
Input Leakage Current Low	I _{LIL}			-10	μA	Ports A, C, D, $\overline{\text{INT}}$, RESET, V _I = 0V
Clock Input Leakage Current High	I _{LφH}			+200	μA	CL ₀ Input, V _{φH} = V _{CC}
Clock Input Leakage Current Low	I _{LφL}			-200	μA	CL ₀ Input, V _{φL} = 0V
Output Voltage High	V _{OH1}	V _{CC} -0.5			V	Ports C through G, I _{OH} = -1.0 mA
	V _{OH2}	V _{CC} -2.5			V	Ports C through G, I _{OH} = -2.0 mA
Output Voltage Low	V _{OL1}			+0.6	V	Ports E, F, G, I _{OL} = +2.0 mA
	V _{OL2}			+0.4	V	Ports E, F, G, I _{OL} = +1.2 mA
Output Leakage Current Low	I _{LOL}			-10	μA	Ports C, D, V _O = 0V
Supply Current	I _{CC}		+0.8	+2.0	mA	

T_a = 25°C

CAPACITANCE

PARAMETER	SYMBOL	LIMITS			UNIT	TEST CONDITIONS
		MIN	TYP	MAX		
Input Capacitance	C _I			15	pF	f = 1 MHz
Output Capacitance	C _O			15	pF	
Input/Output Capacitance	C _{IO}			15	pF	

T_a = -30°C to +85°C; V_{CC} = +5V ± 10%

AC CHARACTERISTICS

PARAMETER	SYMBOL	LIMITS			UNIT	TEST CONDITIONS
		MIN	TYP	MAX		
Oscillator Frequency	f	150		440	kHz	External Clock
Rise and Fall Times	t _r , t _f	0		0.3	μs	
Clock Pulse Width High	t _{φWH}	0.5		5.6	μs	
Clock Pulse Width Low	t _{φWL}	0.5		5.6	μs	

CLOCK WAVEFORM

